

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IFW

In the Application of

Hidekazu HOSHINO et al.

Group Art Unit: 2131

Application No.: 10/527,446

Filed: March 11, 2005

Docket No.: 123156

For: OBJECT IDENTIFYING MEDIUM USING MULTI-LAYER THIN-FILM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- ☒ 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- ☒ 2. An English language Abstract of one or more non-English language reference is attached. See References 1-5.
- ☒ 3. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office (<http://www.jpo.go.jp>), and is attached, but has not been reviewed for accuracy. See References 1-5.

Respectfully submitted,



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Sheet 1 of 1

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 123156		APPLICATION NO. 10/527,446	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Hidekazu HOSHINO et al.			
				FILING DATE March 11, 2005		GROUP 2131	
U.S. PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Name			
FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation	
	1	JP-A-2000-064198	02/29/2000	Japan	X	X	
	2	JP-A-2000-112357	04/21/2000	Japan	X	X	
	3	JP-A-2000-284673	10/13/2000	Japan	X	X	
	4	JP-A-09-156198	06/17/1997	Japan	X	X	
	5	JP-A-2000-290896	10/17/2000	Japan	X	X	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
EXAMINER					DATE CONSIDERED		
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

Date: August 28, 2007